MOSFET – Power, Single, N-Channel, μ8FL 30 V, 37 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC–DC Converters
- Power Load Switch
- Notebook Battery Management
- Motor Control

MAXIMUM RATINGS (T_J = $25^{\circ}C$ unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	30	V		
Gate-to-Source Voltage	Gate-to-Source Voltage				
Continuous Drain		T _A = 25°C	۱ _D	11.8	А
Current $R_{\theta JA}$ (Note 1)		T _A = 85°C		8.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	P _D	2.12	W
Continuous Drain		T _A = 25°C	Ι _D	15.9	А
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 85°C		11.5	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} (\text{Note 1})$	Steady	T _A = 25°C	PD	3.86	W
Continuous Drain	State	$T_A = 25^{\circ}C$	۱ _D	7.3	А
Current $R_{\theta JA}$ (Note 2)		T _A = 85°C		5.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	P _D	0.81	W
Continuous Drain		T _C = 25°C	I _D	37	А
Current $R_{\theta JC}$ (Note 1)		T _C = 85°C		27	
Power Dissipation $R_{\theta JC}$ (Note 1)		$T_C = 25^{\circ}C$	P _D	20.8	W
Pulsed Drain Current	I _{DM}	160	А		
Operating Junction and S	T _J , T _{stg}	–55 to +150	°C		
Source Current (Body Die	۱ _S	20	А		
Drain to Source dV/dt	Drain to Source dV/dt				V/ns

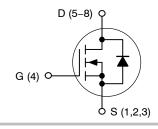


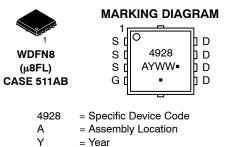
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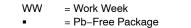
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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	9.0 m Ω @ 10 V	37 A
30 V	13.5 mΩ @ 4.5 V	57 A

N-Channel MOSFET







(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4928NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4928NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 50 V, V_{GS} = 10 V, I_L = 20 A _{pk} , L = 0.1 mH, R _G = 25 Ω)	E _{AS}	20	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability. 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ extsf{ heta}JC}$	6	°C/W
Junction-to-Ambient - Steady State (Note 3)	R _{θJA}	59.1	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	154.5	
Junction–to–Ambient – (t \leq 10 s) (Note 3)	$R_{\theta JA}$	32.4	

3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				24		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 24 V$	$T_J = 125^{\circ}C$			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$		1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	I _D = 20 A		5.4	9.0	mΩ	
		V _{GS} = 10 V	I _D = 10 A		5.3		
			I _D = 20 A		8.9	13.5	
		V _{GS} = 4.5 V	I _D = 10 A		8.5		
Forward Transconductance	9 FS	V _{DS} = 1.5 V, I _E	₎ = 15 A		40		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				913		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MH	lz, V _{DS} = 15 V		366		
Reverse Transfer Capacitance	C _{rss}				108		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 20 A			8.0		nC
Threshold Gate Charge	Q _{G(TH)}				1.6		
Gate-to-Source Charge	Q _{GS}				3.1	1	
Gate-to-Drain Charge	Q _{GD}				3.1	1	

5. Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.

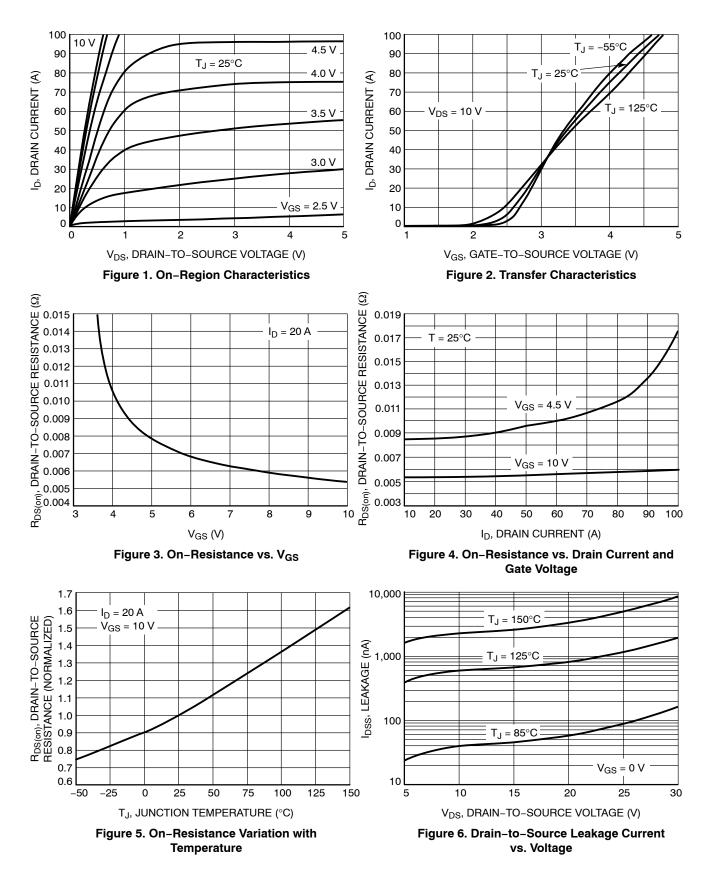
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

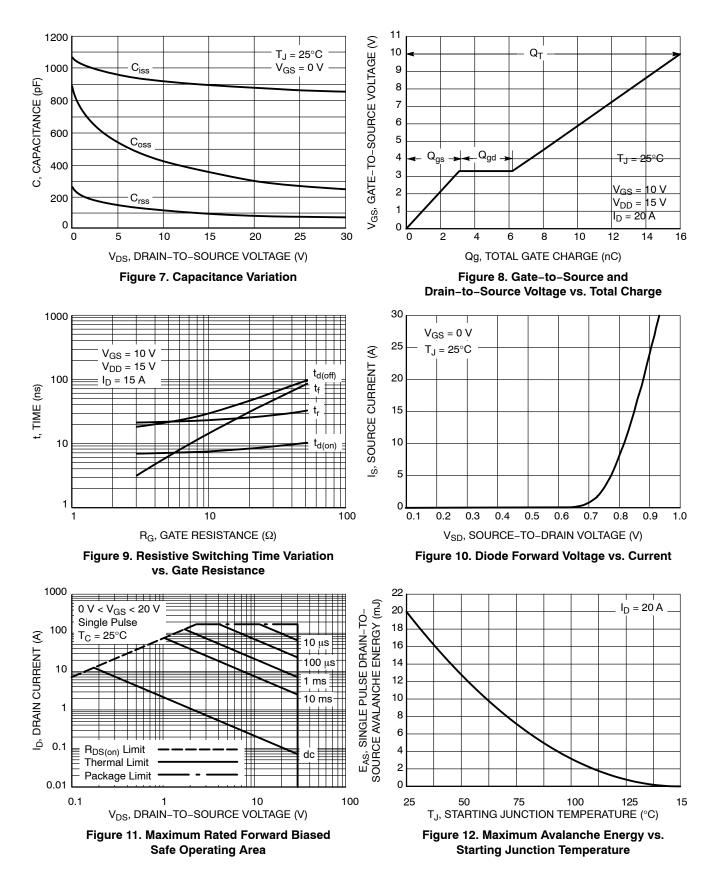
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
CHARGES AND CAPACITANCE	S						
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15	V, I _D = 20 A		16		nC
SWITCHING CHARACTERISTIC	S (Note 6)						
Turn-On Delay Time	t _{d(on)}				9.2		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS}	= 15 V,		25.5		
Turn-Off Delay Time	t _{d(off)}	V_{GS} = 4.5 V, V_{DS} I_D = 15 A, R_G =	3.0 Ω		14		
Fall Time	t _f				4.4		
Turn-On Delay Time	t _{d(on)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			6.5		ns
Rise Time	t _r				21		
Turn-Off Delay Time	t _{d(off)}				18		
Fall Time	t _f				3.0		
DRAIN-SOURCE DIODE CHARA	ACTERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.87	1.1	V
		V _{GS} = 0 V, I _S = 20 A	$T_J = 125^{\circ}C$		0.76		
Reverse Recovery Time	t _{RR}		•		21.4		ns
Charge Time	ta	$V_{GS} = 0 V, d_{IS}/d_{t} =$	100 A/μs,		10.5		
Discharge Time	t _b	$V_{GS} = 0 \text{ V}, \text{ d}_{IS}/\text{d}_t = I_S = 20 \text{ A}$			10.9		
Reverse Recovery Charge	Q _{RR}		ľ		8.4		nC
PACKAGE PARASITIC VALUES							-
Source Inductance	L _S				0.38		nH
Drain Inductance	LD	T _A = 25°C			0.054		
Gate Inductance	L _G				1.3		
Gate Resistance	R _G				0.9		Ω

5. Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

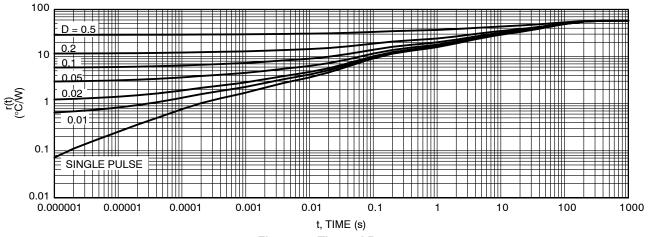
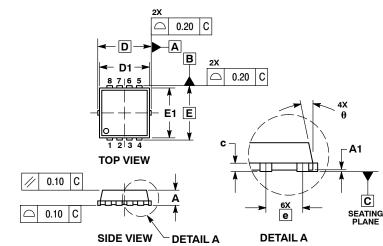
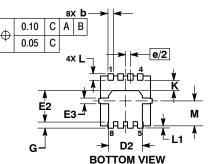


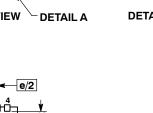
Figure 13. Thermal Response

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB **ISSUE D**







NOTES

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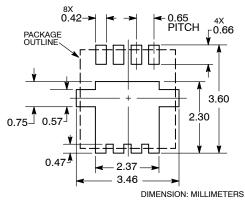
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 1. 2

CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH

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ROTRU	SIONS	OR G	ATE	BURRS	5.

	MILLIMETERS				INCHES				
DIM	MIN	NOM	MAX	MIN	NOM	MAX			
Α	0.70	0.75	0.80	0.028	0.030	0.031			
A1	0.00		0.05	0.000		0.002			
q	0.23	0.30	0.40	0.009	0.012	0.016			
c	0.15	0.20	0.25	0.006	0.008	0.010			
D		3.30 BSC		0	.130 BSC)			
D1	2.95	3.05	3.15	0.116	0.120	0.124			
D2	1.98	2.11	2.24	0.078	0.083	0.088			
Е		3.30 BSC			.130 BSC)			
E1	2.95	3.05	3.15	0.116	0.120	0.124			
E2	1.47	1.60	1.73	0.058	0.063	0.068			
E3	0.23	0.30	0.40	0.009	0.012	0.016			
е		0.65 BSC			0.026 BS	0			
G	0.30	0.41	0.51	0.012	0.016	0.020			
к	0.65	0.80	0.95	0.026	0.032	0.037			
L	0.30	0.43	0.56	0.012	0.017	0.022			
L1	0.06	0.13	0.20	0.002	0.005	0.008			
Μ	1.40	1.50	1.60	0.055	0.059	0.063			
θ	0 °		12 °	0 °		12 °			

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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